

Notice of References Cited	Application/Control No. 10/523,827		Applicant(s)/Patent Under Reexamination BIES, RICHARD J.	
	Examiner Nnenna N. Ekpo		Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

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